

<b>Notice of References Cited</b>	Application/Control No. 10/028,289	Applicant(s)/Patent Under Reexamination HA ET AL.	
	Examiner Jeanne A. Di Grazio	Art Unit 2871	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,552,764	04-2003	Fujioka et al.	349/106
	B	US-6,400,439	06-2002	Fujioka et al.	349/153
	C	US-6,366,331	04-2002	Sakamoto et al.	349/43
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-02-220032	09-1990	Japan	OBARA et al.	G02F 1/1345
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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